

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination KIM ET AL.	
		Examiner CongVan Tran	Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0103445 A1	06-2003	Steer et al.	370/208
*	B	US-2003/0161285 A1	08-2003	Tiedemann et al.	370/332
*	C	US-2004/0057394 A1	03-2004	Holtzman, Jack M.	370/317
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NON-PATENT DOCUMENTS

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